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## **INFORMATION DISCLOSURE** STATEMENT BY APPLICANT

Complete if Known				
Application Number	10/749,607			
Filing Date	12/31/2003			
First Named Inventor	WOLFGANG ROESNER			
Examiner Name	THANGAVELU, KANDASWAMY			
Art Unit	2123			
Attorney Docket No.	AUS920020367US1			

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Date Considered:

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